## THAPAR INSTITUTE OF ENGINEERING AND TECHNOLOGY, PATIALA COMPUTER SCIENCE ENGINEERING DEPARTMENT Mid Semester Test (September 2019) Class/ Sem: BF-MBA(2017) / VI sem

Exam: Mid Semester Test (September 2019)		Class/ Sem: BE-MBA(2017) / VI sem	
Course Code: UCS617	Course Name: Microprocessor based System		
	Designs		
Exam Date: 28-09-2019 (13:00 IST)	Course Instructor: Ms. Harinder Kaur		
All questions are compulsory. Assume the st	andard values for size of data, mem	ory etc.	
wherever not provided.			
Time: 2 hours		arks: 25	
1. (a) With reference to the pin diagram of 8085	5 microprocessor, explain the use of fo	ollowing	
signals:-			
(i) ALE (ii) INTR (iii) IO/M		(3)	
(b) Differentiate between maskable and non-r	naskable Interrupts with examples sui	table to	
8085 microprocessor.		(2)	
2. (a) What will be the contents of accumulator	and carry flag in 8085 after the execu	tion of the	
following code:-		(2)	
MVI A, 89H			
STC			
MVI C, 04H			
LOOP: RAL			
DCR C			
JNZ LOOP			
HLT			
(b) Explain the following instructions of 8085	microprocessor with examples:-	(3)	
(i) XCHG (iii) RRC	(iii) SIM		
3. (a) Differentiate between 8085 and 8086 m	icroprocessor.	(2.5)	
(b) Explain the Interrupt Handling Mechani	sm of 8086 microprocessor.	(2.5)	
ANY AGENTS CONTRACT C			
4. (a) Explain the concept of segmented memo	ry in 8086 microprocessor.	(3)	
(b) The value of Code Segment (CS) Regist	ter is 4042H and the value of different	offsets is	
as given: BX: 2025H, IP: 0580H, DI: 4247H		(2)	
Calculate the effective address of the memory le	ocation pointed by the CS register	(2)	
Calculate the effective address of the memory is			
5. (a) Explain the following instructions of 808	66 microprocessor :-	(2)	
(i) AAA (ii) AA	AM		
(b) Write a program to find count of positive	_		
stored in contiguous memory locations (from			
positive numbers and negative numbers shoul	d be stored at memory locations 400	00 and 4001	
respectively.		<b>(</b> 3)	